

## METHOD OF IMPLEMENTATION - CABLE JITTER

### Abstract

This test checks the amount of jitter added from an electrical cable and connector using the WAVECREST SIA 3000 and a pattern generator. This test is defined for a single lane and must be repeated for each lane of the DUT.

### Coverage:

V2c07-016

### Topology

(1X cable port) PhysicalCable1: Test\_Fixture=LC1X\_sma\_L1, Width=1X

(4X cable port) PhysicalCable1: Test\_Fixture=LC4X\_sma\_L2, Width=4X

(12X cable port) PhysicalCable1: Test\_Fixture=LC12X\_sma\_L3, Width=12X

Two test fixtures are used at each end of the cable.

**Qualifier** None

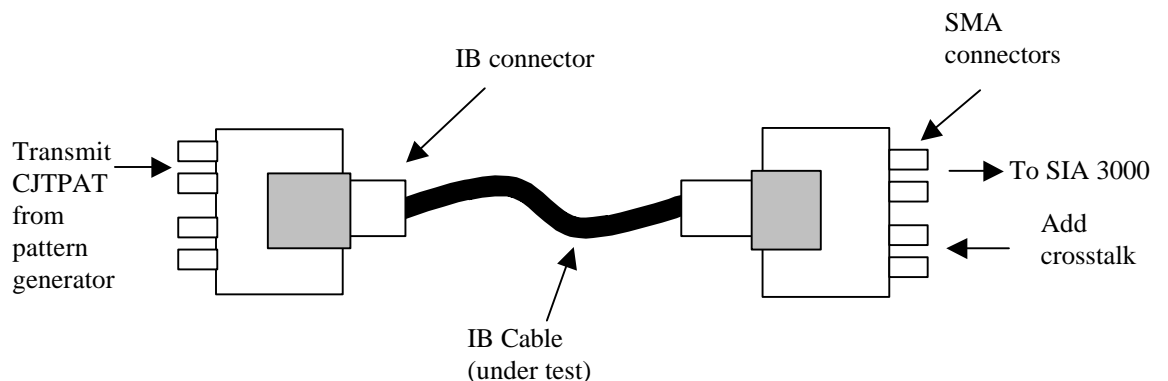
### Notes

1. This test applies to both the cable and cable connector.
2. Test must be performed on each lane in the cable assembly.
3. A crosstalk source may be connected to either side of IB connection under test. Cross talk can be generated by a  $1.6V_{pp}$  signal transmitted asynchronously to the test pattern.
4. Total Jitter is defined as the pk-pk value at the data crossing point. The histogram must contain >10,000 hits for sufficient statistics.
5. Required instruments: SIA 3000 with A32 channel card option and Pattern Generator.

### Dev Notes

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This test requires a cable test fixture. The proposal below is for 1X, 4X and 12X cables.



## ALGORITHM



### Assertions

V2c07-016#05

### Initialization

1. Connect Pattern Generator differential pair to test fixture. Select CJTPAT as the test pattern for the pattern generator, Voltage level=1.6 Vpp, 2.5 Gb/s.
2. Connect SMA differential pair from test fixture output to channel input A of the SIA 3000.
3. For clock-to-data measurements connect the clock from the pattern generator to the channel input B of the SIA 3000.
4. Connect IB cable between IB connector-SMA adapter cards.

### Tester Procedure

1. From the VISI Datcom window select the Random data with bitclock tool.
2. Measure signal voltage by depressing the  button
3. Click  to obtain a histogram with >10,000 hits.
4. Verify TJ pk-pk<0.25 UI or 100 ps. The figure below shows data from a typical acquisition.
5. Test must be performed on each lane of the DUT
6. To measure the effects of crosstalk on 1X, 4X and 12X cable assemblies transmit a 2<sup>7</sup>-1PRBS pattern at >1.3 Gb/s on the adjacent pair and then verify TJ<0.25 UI.

